

MOS FIELD EFFECT TRANSISTOR **2SJ460**

P-CHANNEL MOS FIELD EFFECT TRANSISTOR FOR HIGH SPEED SWITCHING

DESCRIPTION

The 2SJ460 is a switching device which can be driven directly by a 2.5 V power source.

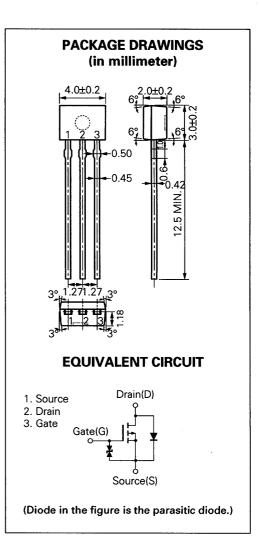
The MOS FET has excellent switching characteristics and is suitable for use as a high-speed switching device in digital circuits.

FEATURES

- Can be driven by a 2.5 V power source.
- Not necessary to consider driving current because of its high input impedance.
- Possible to reduce the number of parts by omitting the bias resistor.

ABSOLUTE MAXIMUM RATINGS (TA = +25 °C)

Drain to Source Voltage	Vdss	-50	v
Gate to Source Voltage	Vgss	∓7.0	v
Drain Current (DC)	D(DC)	∓0.1	А
Drain Current (pulse)	D(pulse)	∓0.2 *	Α
Total Power Dissipation	Ρτ	250	mW
Channel Temperature	Тсн	150	°C
Storage Temperature	Tstg	–55 to +150	°C
*PW ≦10 ms, Duty cycle ≦ 1 %			



The diode connected between the gate and source of the transistor serves as a protector against ESD. When this device is actually used, an additional protection circuit is externally required if a voltage exceeding the rated voltage may be applied to this device.

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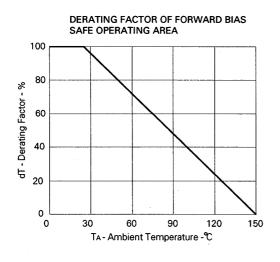
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ELECTRICAL CHARACTERISTICS (TA = +25 °C)

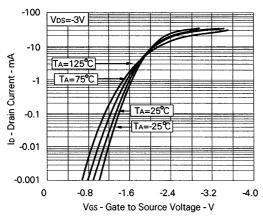
CHARACTERISTIC	SYMBOL	MIN.	TYP.	MAX.	UNIT	TEST CONDITIONS	
Drain Cut-off Current	IDSS			-1.0	μA	VDS = -50 V, VGS = 0	
Gate Leakage Current	lgss			∓3.0	μA	Vgs = 7.0 V, Vds = 0	
Gate Cut-off Voltage	VGS(off)	-0.7	-0.9	-1.3	v	$V_{DS} = -3.0 \text{ V}, \text{ ID} = -1.0 \ \mu\text{A}$	
Forward Transfer Admittance	yfs	12			mS	VDS = -3.0 V, ID = -10 mA	
Drain to Source On-State Resistance	RDS(on)1		46	100	Ω	Vgs = -2.5 V, Id = -3 mA	
Drain to Source On-State Resistance	RDS(on)2		31	50	Ω	Vgs = -4.0 V, Ip = -10 mA	
Input Capacitance	Ciss		6		рF	VDS = -3.0 V, VGS = 0	
Output Capacitance	Coss		9		pF	-	
Reverse Transfer Capacitance	Crss		1.6		pF	f = 1.0 MHz	
Turn-On Delay Time	td(on)		32		ns	VDD = -3.0 V, ID = -20 mA	
Rise Time	tr		270		ns		
Turn-Off Delay Time	td(off)		45		ns	$V_{GS(on)} = -3.0 \text{ V}, \text{ Rg} = 10 \Omega$	
Fall Time	tr		130		ns	RL = 200 Ω	

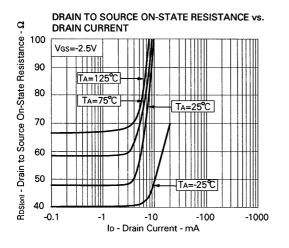
TYPICAL CHARACTERISTICS (TA = 25 °C)

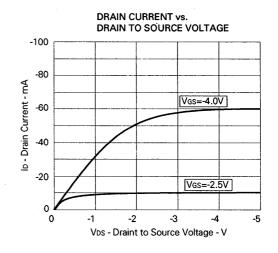
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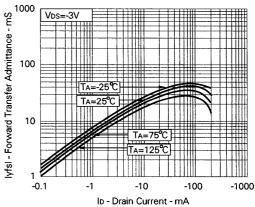
TRANSFER CHARACTERISTICS

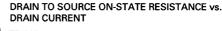


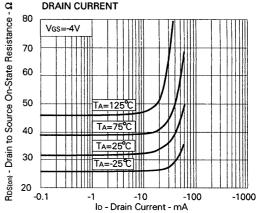




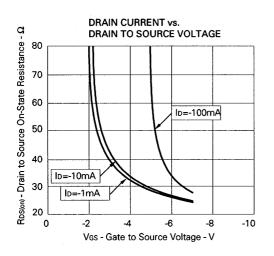
FORWARD TRANSFER ADMITTANCE vs. DRAIN CURRENT

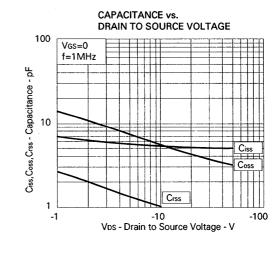




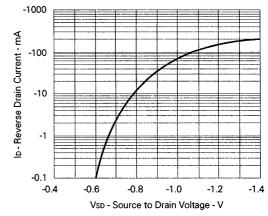


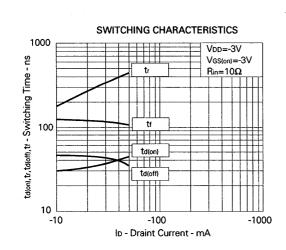
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SOURCE TO DRAIN DIODE FORWARD VOLTAGE





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REFERENCE

Document Name	Document No. TEI-1202		
NEC semiconductor device reliability/quality control system			
Quality grade on NEC semiconductor devices	IEI-1209		
Semiconductor device mounting technology manual	C10535EJ7V0IF00		
Guide to quality assurance for semiconductor devices	MEI-1202		
Semiconductor selection guide	X10679EJAV0SG00		

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Anti-radioactive design is not implemented in this product.

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